Call for Papers: 1988 MRS Spring Meeting

The 1988 Spring Meeting of the Materials Research Society will be held April 5–9 at the Bally Grand Hotel in Reno, Nevada. This year's meeting will feature 15 technical symposia, a short course program of approximately 22 courses, an equipment exhibit, and a job placement center. MRS extends a broad invitation to materials scientists and engineers to participate in all aspects of the meeting.

The symposia will share a common goal of discussing new materials developments, new characterization methods, or new process technology. Each symposium will provide a forum for exchanging ideas at the forefront of research with experts in the field. Topics will be treated at a sophisticated level, in an interdisciplinary way, so all possible physical, chemical, and engineering insights can be considered.

Papers which will contribute to the state of knowledge in a given area are solicited for all symposium topics. The topics for each symposium are described below. For additional information on a specific symposium, contact the symposium organizers listed at the end of the description for each symposium.

Abstracts are to be prepared in the new MRS abstract format and submitted to the organizers of the individual symposia. Except for Symposium K, the deadline for abstracts to be in the hands of the symposium organizers is October 1, 1987. The deadline for Symposium K only is January 10, 1988.

For general information on the technical program, contact any of the Program Chairs:

David E. Clark

Department of Materials Science & Engineering University of Florida Gainesville, FL 32611 (904) 392-7660

Clif Draper

AT&T Engineering Research P.O. Box 900 Princeton, NJ 08540 (609) 639-2350

C.T. Liu

Oak Ridge National Laboratory P.O. Box X Oak Ridge, TN 37831 (615) 574-4459

Symposium A Heteroepitaxy on Silicon: Fundamentals, Structures, and Devices

This symposium will expand the scope of previous MRS symposia on heteroepitaxial growth on silicon by addressing fundamental phenomena of epitaxial growth and investigating specific materials and device systems. Particular emphasis will be placed on: emerging new heteroepitaxial combinations; progress of GaAs/Si, GeSi/Si and epitaxial fluorides and silicides; developments in fundamental understanding, materials growth, and characterization; and emerging device applications such as monolithic III-V/ Si integration, and high temperature wide bandgap semiconductor technologies. Contributions are solicited in the following and related fields:

• Fundamentals of heteroepitaxial growth on Si

• Growth and characterization of heteroepitaxial layers on Si III-V and II-VI compounds on Si

• Group IV heteroepitaxy (GeSi/Si, SiSn/Si and high temperature wide bandgap semiconductors such as SiC/Si)

• Epitaxial metals and insulators on Si

• Novel devices in heteroepitaxial structures on Si

• Monolithic GaAs/Si integration Send abstracts to R.J. Nemanich at the address below.

Symposium Organizers:

Hong K. Choi Lincoln Laboratory Massachusetts Institute of Technology 244 Wood Street Lexington, MA 02173 (617) 863-5500, Ext. 4457

Robert Hull AT&T Bell Laboratories 600 Mountain Avenue Murray Hill, NJ 07974 (201) 582-3000

Hiroshi Ishiwara Tokyo Institute of Technology 4259 Nagatsuda Yokohama 227, Japan 011-81-45-922-1111, Ext. 2552

Robert J. Nemanich Department of Physics North Carolina State University Raleigh, NC 27695-8202 (919) 737-3225

Symposium B Materials for Controlled-Release Environments

This symposium will highlight recent developments in materials for controlledrelease application. It will be interdisciplinary, emphasizing scientific and engineering developments in polymer science, ceramics, and metals that are important in the design of controlled-release systems in pharmaceutics, agriculture, and environmental science. Areas of interest include transdermal and implantable drug delivery systems, pesticide and animal health care products, environmental reclamation, sensors, diagnostics, and lithography. Contributions are solicited in the following areas:

Diffusion in polymers

Biodegradable/bio-erodible polymers

- Swelling of polymers in biological fluids
- Transdermals

• Ceramic and metal-based controlled release

 Bioadhesion and biological surface interactions with materials

- Biosensors
- Materials effects on protein stability

Symposium Organizers:

Kristine Knutson Department of Pharmaceutics University of Utah Salt Lake City, UT 84112 (801) 581-4426

Robert Langer Room 342, Whitaker Health Science Building Massachusetts Institute of Technology Cambridge, MA 02139 (617) 253-3107

Ronald A. Siegel School of Pharmacy, 926-S University of California San Francisco, CA 94143 (415) 476-5194

Symposium C Process Diagnostics

Materials and process development is often done using the Edisonian approach of varying one process parameter at a time and observing changes in some desired material property. As processes (e.g. microelectronic fabrication) increase dramatically in their complexity, the validity of this method is called into question, particularly in light of new diagnostic techniques which provide a microscopic view of atomic and molecular interactions. This symposium is designed to bring together scientists and engineers who are attempting to obtain a fundamental understanding of processes occurring in the gas phase and at gas/solid and gas/liquid interfaces. Its goal is to create a dialogue between scientists and engineers who are already using sophisticated diagnostic techniques to study combustion and magnetic confinement fusion processes and material scientists who wish to increase their understanding of how process parameters affect microelectronic fabrication, coating technologies, and ceramic and metallurgical processing

Contributions are solicited in the following areas:

• Process diagnostics for microelectronics fabrication (PVD, CVD, PECVD, plasma etching...)

• Process diagnostics for industrial coating technologies (plasma spraying, PVD, CVD, PECVD...)

• Diagnostics for ceramic and metallurgical processing (powder synthesis, welding, melting, refining, surface modification...)

Combustion diagnostics (internal combus-

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tion engines, rocket engines, explosive detonations...)

• Magnetic confinement fusion diagnostics (plasma-surface interactions, edge diagnostics...)

Symposium Organizers:

Kay Hays Division 1831 Sandia National Laboratories Albuquerque, NM 87185 (505) 844-9996

Alan Eckbreth United Technologies Research Center Silver Lane E. Hartford, CT 06108 (203) 727-7269

Greg Campbell Center for Plasma Physics & Fusion Engineering University of California Los Angeles, CA 90024 (213) 825-3419 or (818) 841-4094

Symposium D Diamond and Diamond-Like Materials Synthesis

Over the past 30 years, researchers have synthesized single-phase diamond films using thermal-, catalyst-, photon (UV)-, and electron-assisted CVD; rf- and microwaveplasma-assisted CVD and sputtering techniques. Polycrystalline and continuous single phase diamond films, as well as diamond crystals, have been deposited using a variety of hydrocarbon gases.

This symposium will focus on these films' physical and chemical properties, as well as their performance properties in potential applications. These properties will be discussed as a function of the deposition techniques and their parameters. The roles of plasma chemistry, nonequilibrium kinetics, and film morphology and characterization will also be addressed.

Speakers should submit five copies of their abstracts.

Symposium Organizers:

George H. Johnson Electronic Specialties Laboratory Philips and Du Pont Optical Company E.I. du Pont de Nemours & Company Chestnut Run Bldg. 709 Laboratory 7 Wilmington, DE 19898 (302) 999-4814

Michael Geis Lincoln Laboratory Massachusetts Institute of Technology P.O. Box 73 Lexington, MA 02173-0073

(617) 863-5500, Ext. 4658

Andrzej Badzian Materials Research Laboratory Pennsylvania State University University Park, PA 16802 (814) 863-1967

Symposium E Amorphous Silicon Technology

This symposium will be devoted to materials issues related to applications to amorphous semiconductors, including amorphous silicon-based alloys. Specific issues will include structure, electronic and optical properties, defects, interfaces, contacts, heterostructures, nonequilibrium behavior, and stability. Applications will include solar cells, electro-photography, switching, electronic and optical memories, image sensors, scanners, thin-film transistors, vidicons, large-area displays, portable computers, and new types of devices. Presentations will focus on the electronic density of states and its relationship to technological figures of merit for each application, fundamental and materials limitations, yield, reproducibility, reliability, and stability.

Papers are solicited, but not limited to the following areas: structure, optical properties, electronic properties, defects, contacts, interfaces, heterostructures, nonequilibrium properties, solar cells, electrophotography, switching, electronic memories, optical memories, computers, large-area displays, vidicons, image sensors, scanners, novel devices, stability, transient behavior, alloys.

Send abstracts to A. Madan at the address below.

Symposium Organizers:

Y. Hamakawa Osaka University 1-1 Machikaneyma Toyonaka, Osaka 560 Japan

P.G. LeComber University of Dundee Carnegie Laboratory of Physics Dundee DD1 4HN UK 44-382-23181

A. Madan Glasstech Solar, Inc. 12441 West 49th Avenue Wheatridge, CO 80033 (303) 425-6600

P.C. Taylor University of Utah Department of Physics Salt Lake City, UT 84112 (801) 581-4484

M.J. Thompson Xerox PARC 3333 Coyote Hill Road Palo Alto, CA 94304 (415) 494-4561

Symposium F Adhesion in Solids

Adhesion of surfaces in contact is of interest to those seeking a fundamental understanding of metals, polymers, superconductors, semiconductors, and ceramics and their applications. This symposium will bring together scientists and engineers to promote the dissemination of ideas, theories, and facts relating to adhesion, adhesion failure, and adhesion promoting or preventing processes. General areas of interest include: interface structure and characterization; mechanics and fracture of interfaces; degradation of adhesion (e.g. corrosion, diffusion); thin film formation—nucleation, interface formation, film properties; modification of surfaces and interfaces to promote or prevent adhesion; techniques for measuring and evaluating adhesion.

Contributions are solicited in such areas as:

- Adhesion or corrosion layers
- Ion beam processing
- Device contacts
- Real-time fracture analysis
- Plasma treatment of polymer surfaces
- Device packaging
- Friction of ceramic surfaces
- Degradation of metal-polymer interfaces
- Coating adhesion in mechanical applications
- Sintering of powders
- Environmental effects on wear
- Adsorption and nucleation of surfaces
- Diffusion at interfaces
- Bioadhesion
- Fine particle adhesion

Symposium Organizers:

D.M. Mattox 1834 Surface and Interface Technology Sandia National Laboratories Albuquerque, NM 87185 (505) 844-7632

Chris Batich Materials Science & Engineering Dept. University of Florida Gainesville, FL 32611 (904) 392-6630

J.E.E. Baglin IBM Almaden Research Center K34/802 650 Harry Road San Jose, CA 94120-6099

R.J. Gottschall ER 131:MS G236/GTN Division of Materials Sciences USDOE Washington, DC 20545 (301) 353-3428

Symposium G High Temperature/High Performance Composites

This symposium will bring together researchers from widely dispersed fields to compare their latest results concerning the synthesis, structure-property relationships, and mechanics of metal, intermetallic, glass, and ceramic matrix composites. Both artificial and *in situ* reinforced composites (produced by co-deformation, controlledeutectic solidification, and reactively formed

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reinforcements) will be addressed. The reinforcement formats comprise continuous filaments, whiskers, and particulates.

Contributions are solicited in the topical areas described above. Emphasis will be placed on new methods of preparation and characterization, new material systems, composition-property relationships, and process effects on properties.

Submit abstracts to F.D. Lemkey at the address below.

Symposium Organizers:

F.D. Lemkey

United Technologies Research Center, MS 25 E. Hartford, CT 06108 (203) 7277318

A.G. Evans Eng. II, Rm. 1355 University of California Santa Barbara, CA 93106 (805) 961-3141

S.G. Fishman Office of Naval Residence 800 N. Quincy Street Arlington, VA 22217 (202) 696-4401

J.R. Strife

United Technologies Research Center, MS 24 E. Hartford, CT 06108 (203) 7277270

Symposium H

Better Ceramics Through Chemistry III

This symposium will address the synthesis, structure and new applications of chemically derived ceramic materials. The first sessions will address the chemistry and structure of ceramic precursors. Subsequent sessions will address forming these substances into gels, films, powders, or fibers, and conversion to glasses, ceramics, or composites. Recent results on films and coatings will also be emphasized. A session on chemical processing of high temperature superconductors has been tentatively planned. Contributions are solicited in the following areas:

 Synthesis and chemistry of ceramic precursors

• Chemical routes to gels, powders, films or fibers

 Structure and structure-property relationships

Advances in materials characterization

• Films and coatings: synthesis, structure and applications

• Theoretical modeling: MO/MD calculations, computer simulations

• Joining: sealing and repair

Processing of high temperature superconductors

Submit two copies of the abstract to C. Jeffrey Brinker at the address below.

Symposium Organizers:

C. Jeffrey Brinker

Div. 1846

Sandia National Laboratories Albuquerque, NM 87185 (505) 846-3552

D.E. Clark

Dept. of Materials Science & Engineering University of Florida Gainesville, FL 32611 (904) 392-7660

Don R. Ulrich Air Force Office of Scientific Research Bolling Air Force Base Washington, DC 20332 (202) 767-4963

Symposium J Science and Technology of Refractory Alloys

Interest in refractory metals for advanced engineering systems and electronic applications has grown substantially in the last few years. To date, this interest has expanded without the benefit of timely symposia on these applications and the new base of applied and fundamental knowledge that has been generated over the past decade. This symposium will focus on new applications and determine the state of knowledge. Contributions are solicited in the following areas: Current and anticipated applications, such as electronics and aerospace (e.g., propulsion, reentry), space power, fusion and other radiation environments, VLSI metallization, specialized applications (e.g., capacitors, filaments, heating elements, electrodes, x-ray targets)

• Applied technology considerations, such as: processing (e.g., joining, forming, machining, melting, PM), coatings (e.g., PVD, CVD, sputtering, slurry fusion, diffusion barriers), environmental reactions and compatibility (e.g., oxidation, atomic oxygen, hydrogen, inert gases, high vacuum, alkali metals, propulsion gases, liquid and solid propellants)

• Fundamental topics, such as: alloy design, diffusion, microstructural control, deformation and fracture mechanisms, gas-metal interactions, phase equilibrium, reaction kinetics (e.g., silicide formation), thermal, electrical, electronic and optical properties, solidification phenomena

Symposium Organizers:

Roy H. Cooper, Jr. Oak Ridge National Laboratory P.O. Box X Oak Ridge, TN 37831-6153 (615) 574-4470

Ronald Gibala Dept. of Materials Science & Engineering University of Michigan Ann Arbor, MI 48109-2136 (313) 763-4970

Charles M. Packer Lockheed Palo Alto Research Center 3251 Hanover Street Palo Alto, CA 94304-1187 (415) 424-2267

Jeffrey Wadsworth Lockheed Palo Alto Research Center 3251 Hanover Street Palo Alto, CA 94304-1191 (415) 424-2234

Symposium K High Temperature Superconductors

This symposium will provide a multidisciplinary forum focused on the exciting new developments in high temperature superconductivity. Contributions are solicited in the following areas:

• Superconducting properties (T_c , H_{c2} , J_c , etc.)

• Électron-electron coupling mechanisms and prospects for higher TcS

Materials properties and microstructure

• Processing, fabrication and characterization

Current and future applications

Contributing speakers should submit five copies of abstracts to D. Capone by January 10, 1988.

Symposium Organizers:

Bertram Batlogg AT&T Bell Laboratories Room 1D237 600 Mountain Avenue Murray Hill, NJ 07974-2070 (201) 582-6663

W.H. Butler Oak Ridge National Laboratory Building 4500S, MS-114 P.O. Box X Oak Ridge, TN 37831-6114 (615) 574-4845

Don Capone Argonne National Laboratories Building 223, Room A113 9700 South Cass Avenue Argonne, IL 60439 (312) 972-5526

Paul C.W. Chu Department of Physics University of Houston Houston, TX 77004 (713) 749-2842

Symposium L Materials Issues in Art and Archaeology

Cosponsored by the Getty Conservation Institute and Conservation Analytical Laboratory, Smithsonian Institution

The methods and analytical techniques of materials science have been central to advances in art history, archaeology and conservation. Recent developments in materials research have been applied to problems such as authenticity, preservation, dating, provenance, raw materials sourcing, and understanding the diversity and complexity of ancient technologies. In addition, there is a growing body of research data on ancient

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technology which has developed within the field of archaeometry on systems which should be of interest to university or industrial materials researchers.

Contributions are solicited in the following areas:

• Technical methods of examining and characterizing artifacts and works of art (e.g., materials characterization and methods of analysis in art and archaeology, in particular nondestructive and microsampling techniques)

 Technical studies of the technologies of ancient and historic manmade materials (e.g., metals, ceramics and polymers), including investigation of properties, reconstruction of processing, characterization of macro- and microstructure, role of technology in social evolution, interaction of technologies, processes of technological innovation and development

• Deterioration of natural, ancient and modern glasses: models, mechanisms and treatment

Submit three copies of camera-ready abstracts.

Symposium Organizers:

Edward V. Sayre and Pamela Vandiver Conservation Analytical Laboratory Smithsonian Institution Washington, DC 20560 (202) 287-3700

James Druzik Getty Conservation Institute 4503 Glencoe Avenue Marina Del Rey, CA 90292 (213) 822-2299

Christopher Stevenson Archaeological & Historical Consultants, Inc. P.O. Box 182 Boalsburg, PA 16827

(814) 466-7549

Symposium M Microwave Processing of Materials

Endorsed by the American Ceramic Society This is the first major international symposium on the use of microwave energy applied to materials processing, including industrial applications. Speakers will highlight progress and recent developments in the microwave processing of materials and products from research, development, and production viewpoints. Contributions are solicited in such areas as:

• Fundamentals of microwaves/materials interactions and modeling; microwavemicrostructure-property relationships

 Application of M/W to inorganic materials, including ceramics, glasses, glass-ceramics, non-oxides, composites, minerals

• Application of M/W to organic materials, including: polymers, adhesives, rubber, tex-tiles, forest products, and food

• Application of M/W to medical and biological systems

• Examples of technological applications of the above, including reclamation and pollution control

Symposium Organizers:

Merton H. Brooks Sandia National Laboratories Division 7472 Albuquerque, NM 87115 (505) 844-6800

Irving J. Chabinsky I.J.C. Technologies, Inc. 8 Paul Revere Rd. Acton, MA 01720 (617) 263-7911

Willard H. Sutton United Technologies Research Center MS-24, Silver Lane East Hartford, CT 06108 (203) 727-7639

Symposium N Materials Stability and Environmental Degradation

This symposium will focus on scientific advances in understanding the mechanisms of corrosion and degradation of such materials as metals, glass and ceramics, polymers, and composites. Topics of interest include the dependence of rates and mechanisms of environmental degradation on materials composition and fabrication as well as on environmental conditions.

Contributions are solicited in the general area of mechanisms of degradation, dissolution, stress corrosion, and oxidation, as well as the development of materials of high stability in specific environments, including:

• Ceramics and alloys for high temperature applications

• Homogenous and composite structural materials

• Optical components and fibers based on oxide and non-oxide glasses

Radiation-resistant alloys and ceramics

• Materials with high biological stability for

environmental and biomedical applications • Natural, ancient and modern glasses, ceramics, and metals

Symposium Organizers:

L.R. Smith Polymer Division, Rm. A305 National Bureau of Standards Gaithersburg, MD 20899 (301) 975-6762

E. Verink 706 Clopper Rd., Apt. 22 Gaithersburg, MD 20878 (301) 975-6027

A. Barkatt Vitreous State Laboratory Catholic University of America Washington, DC 20064 (202) 635-5522

Symposium P Advanced Surface Processes for Optoelectronics

Major advances in preparing and processing material surfaces could significantly influence the future of optoelectronics. This symposium will bring together researchers from a variety of disciplines who are involved in the various aspects of modifying and preparing surfaces with desired electronic and optical properties. Contributions are solicited in the following areas:

• Focused ion beams for direct doping, etching and deposition

• Enhancement of intermixing of superlattice layers by introduction of dopants

• Ion-implanted waveguides in insulators and semiconductors

• Beam-induced etching of optoelectronic structures

Beam-enhanced epitaxial growth

Ion implantation and RTA in III-V materials
Optoelectronics on silicon (oxides, nitrides,

epi-insulators and compound semiconductors)

Strained layer superlattices

Novel ohmic contacts to III-V materials

- Passivation layers for devices
- Fabrication of ultrasmall structures

In situ processing

Symposium Organizers:

T. Venkatesan Bellcore Red Bank, NJ 07701 (201) 758-3254 or (201) 699-2223

S. Bernasek Department of Chemistry Princeton University Princeton, NJ 08544 (609) 452-4986

G. Stillman Dept. of EE & Computer Engineering University of Illinois 1406 W. Green Street Urbana, IL 61801 (217) 333-3097

H. Temkin Rm. 7A-213 AT&T Bell Laboratories Murray Hill, NJ 07974 (201) 582-3185

1988 MRS Spring Meeting April 5-9 Reno, Nevada



A roster of 29 short courses on advanced materials research techniques will complement the technical program at the 1987 MRS Fall Meeting. The courses have been scheduled to give short course attendees time to participate in symposia with parallel topics. Individuals registered for two or more short course days may attend the 1987 MRS Fall meeting at the special fee of \$50.

Space in the short courses is limited register early!

	Courses	Date	Instructors	Tuition*
NEW	Conventional and High Temperature Superconductors Crystalline Polymers	Nov. 29 Dec. 4	T.P. Orlando	\$270 320
Contraction of the second	Liquid Phase Epitaxy Techniques	Nov. 30-Dec. 1	L.B. Dawson	485
	Molecular Beam Epitaxy	Dec. 4-5	G.W. Wicks	485
	Vapor Phase Epitaxy	Dec. 2-3	P.D. Dapkus and H.M. Cox	485
	Film Formation, Adhesion, and		·	
	Surface Preparation	Dec. 4	D.M. Mattox	320
	Plasma Enhanced CVD of Thin Films			
	for Microelectronics	Nov. 30	R. Reif	320
	Implantation and Diffusion	Dec. 4	T.E. Seidel	320
	Rapid Thermal Processing	Dec. 5	T.E. Seidel and S.C. Shatas	320
FIN	Froton-Controlled Processing	Dec 4	P.M. Orgood Jr	220
NY	Silicon Epitavy: Present and Euture	Dec. 4	R Reif	320
and a start of the start	Plasma Etching for Microelectronic	000.4	TI. Hen	020
	Fabrication	Dec. 3	G.K. Herb	320
	Ion Beam Processes for Materials			
	Modification	Dec. 4	J.K. Hirvonen	320
	Microelectronic Packaging: Materials,			
	Processing, and Reliability	Dec. 3-5	S.K. Prasad and R.K. Shukla	710
	Modern Materials Analysis Techniques	Nov. 30-Dec. 2	J.A. Borders, K.H. Eckelmeyer, and S.H. Weismann	740
	Electron Microscopy of Thin Films	Dec. 4-5	A.D. Romig, Jr. and D.B. Williams	485
	Surface and Thin Film Analysis	Dec. 4-5	L.C. Feldman and J.W. Mayer	510
	Characterization of Films, Coatings,			
	and Surfaces	Dec. 5	D.M. Mattox	320
	Application of Reflection Electron	Dec 2	B.L. Cohon	200
	Deep Level Transient Spectroscopy	Nov 30	C.E. Barnes	320
aN	Fractals in Materials Science	Nov. 30	J.E. Martin and A.J. Hurd	320
NEW	Characterization of Powders and Porous			Bernary Ker
142	Materials	Nov. 30-Dec. 1	D.M. Smith and J.E. Shields	485
	IC Failure Mechanisms and Analytical			
	Techniques	Dec. 2-3	G. Riga	485
IFN	to Materials Problems	Dec. 3-4	G.D.W. Smith and M. K. Miller	510
Mr	Theory and Practice	Nov. 30	R.J. Hamers	320
N	Nuclear Magnetic Resonance	Dec	LD Vasinawski	200
IFIN	Scanning Electron Microscopy and	Dec. 2	J.F. TESITOWSKI	320
Nr	X-Ray Microanalysis	Dec. 1	D.C. Joy and D.E. Newbury	340
	Catimizing Process Variables	Dec 1-4	D.H. Doeblert	850
	Vacuum and Plasma Technology for	D00. 1-4	D.H. DOGINGI	000
	Materials Processing	Dec. 1-2	D.M. Mattox	485

*Tuition discounts are available to registrants attending certain groups of courses and to students. All registrations made after November 16, 1987 will be \$25 higher for each course. For further details or to register, contact:

Materials Research Society, 9800 McKnight Road, Suite 327, Pittsburgh, PA 15237; telephone (412) 367-3003.